

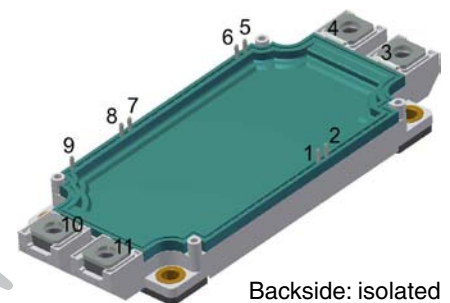
XPT IGBT Module

$$\begin{aligned} V_{CES} &= 2 \times 650 \text{ V} \\ I_{C25} &= 750 \text{ A} \\ V_{CE(sat)} &= 1.5 \text{ V} \end{aligned}$$

Phase leg + free wheeling Diodes + NTC

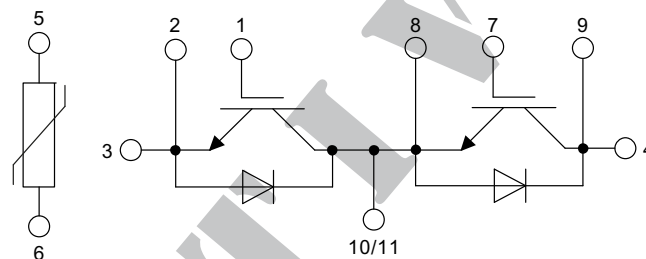
Part number

MIXD600PF650TSF



Backside: isolated

 E72873



Features / Advantages:

- High level of integration - only one power semiconductor module required for the whole drive
- Rugged XPT design (Xtreme light Punch Through) results in:
 - short circuit rated for 10 μ sec.
 - very low gate charge
 - low EMI
 - square RBSOA @ 2x I_c
- Trench XPT design
 - low V_{CEsat}
 - low E_{off}
- Temperature sense included
- SONIC™ diode
 - fast and soft reverse recovery
 - low operating forward voltage

Applications:

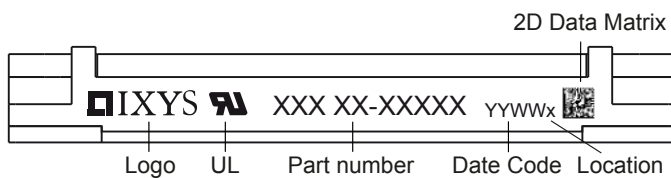
- AC motor drives
- Pumps, fans
- Air-conditioning system
- Inverter and power supplies
- UPS

Package: SimBus F

- Isolation Voltage: 3000 V~
- Industry standard outline
- RoHS compliant
- Soldering pins for PCB mounting
- Height: 17 mm
- Base plate:
 - Copper internally DCB isolated
- Advanced power cycling

IGBT			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{CES}	collector emitter voltage	$T_{VJ} = 25^{\circ}\text{C}$ to 125°C			650	V
V_{GES}	max. DC gate voltage				± 20	V
V_{GEM}	max. transient gate emitter voltage				± 30	V
I_{C25}	collector current	$T_C = 25^{\circ}\text{C}$			850	A
I_{C80}		$T_C = 80^{\circ}\text{C}$			640	A
P_{tot}	total power dissipation	$T_C = 25^{\circ}\text{C}$			1500	W
$V_{CE(sat)}$	collector emitter saturation voltage (on die level)	$I_C = 600\text{ A}; V_{GE} = 15\text{ V}$		1.5 1.7	1.7	V V
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 9.6\text{ mA}; V_{GE} = V_{CE}$	5	5.8	6.5	V
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0\text{ V}$			1.8	mA
		$T_{VJ} = 25^{\circ}\text{C}$ $T_{VJ} = 150^{\circ}\text{C}$		2		mA
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20\text{ V}$			1.5	μA
$Q_{G(on)}$	total gate charge	$V_{CE} = 300\text{ V}; V_{GE} = 15\text{ V}; I_C = 600\text{ A}$		960		nC
$t_{d(on)}$	turn-on delay time	inductive load $V_{CE} = 300\text{ V}; I_C = 600\text{ A}; L_S = 30\text{ nH}$ $V_{GE} = \pm 15\text{ V}; R_G = 3.3\text{ }\Omega$ $T_{VJ} = 150^{\circ}\text{C}$		80		ns
t_r	current rise time			100		ns
$t_{d(off)}$	turn-off delay time			250		ns
t_f	current fall time			60		ns
E_{on}	turn-on energy per pulse			15		mJ
E_{off}	turn-off energy per pulse			25		mJ
RBSOA	reverse bias safe operating area	$V_{GE} = \pm 15\text{ V}; R_G = 3.3\text{ }\Omega$ $V_{CEmax} = 650\text{ V}$			1200	A
SCSOA	short circuit safe operating area	$V_{CEmax} = 650\text{ V}$ $V_{CE} = 360\text{ V}; V_{GE} = \pm 15\text{ V};$ $R_G = 3.3\text{ }\Omega$; non-repetitive			10	μs
t_{SC}	short circuit duration	$T_{VJ} = 150^{\circ}\text{C}$		2400		A
I_{SC}	short circuit current					
R_{thJC}	thermal resistance junction to case				0.073	K/W
R_{thCH}	thermal resistance case to heatsink			0.05		K/W
Diode						
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^{\circ}\text{C}$			650	V
I_{F25}	forward current	$T_C = 25^{\circ}\text{C}$			820	A
I_{F80}		$T_C = 80^{\circ}\text{C}$			590	A
V_F	forward voltage (on die level)	$I_F = 600\text{ A}$		1.60 1.70	1.90	V V
Q_{rr}	reverse recovery charge	$V_R = 300\text{ V}$ $-di_F/dt = 4600\text{ A}/\mu\text{s}$ $I_F = 600\text{ A}; V_{GE} = 0\text{ V}$ $T_{VJ} = 150^{\circ}\text{C}$		33		μC
I_{RM}	max. reverse recovery current			350		A
t_{rr}	reverse recovery time			170		ns
E_{rec}	reverse recovery energy			tbd		mJ
R_{thJC}	thermal resistance junction to case				0.085	K/W
R_{thCH}	thermal resistance case to heatsink			0.04		K/W

Package SimBus F				Ratings			
Symbol	Definitions	Conditions		min.	typ.	max.	Unit
I_{RMS}	RMS current	per terminal					A
T_{stg}	storage temperature			-40		125	°C
T_{op}	operation temperature			-40		150	°C
T_{vj}	virtual junction temperature			-40		175	°C
Weight					350		g
M_D	mounting torque			3		6	Nm
M_T	terminal torque			3		6	Nm
$d_{Spp/App}$	creepage distance on surface /	terminal to terminal		12.7			mm
$d_{Spb/Apb}$	striking distance through air	terminal to backside		10.0			mm
V_{ISOL}	isolation voltage	50/60 Hz, RMS, $I_{ISOL} \leq 1$ mA	t = 1 second t = 1 minute	3000 2500			V V
$R_{term-chip}$	resistance terminal to chip	$V = V_{CEsat} + 2 \cdot R_{term-chip} \cdot I_C$ resp. $V = V_F + 2 \cdot R_{term-chip} \cdot I_F$			0.65		mΩ

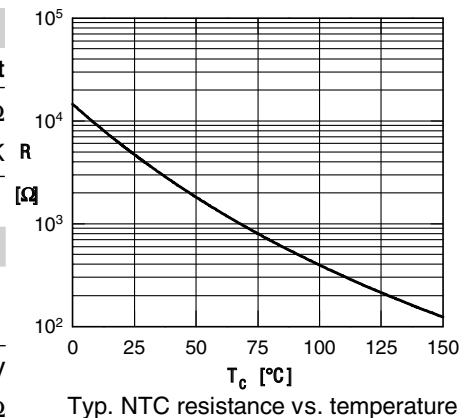
**Part number**

M = Module
 I = IGBT
 X = XPT
 D = Trench 1 / std
 600 = Current Rating [A]
 PF = Phase leg + free wheeling diode
 650 = Reverse Voltage [V]
 T = NTC
 SF = SimBus F

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MIXD600PF650TSF	MIXD600PF650TSF	Box	3	

Temperature Sensor NTC						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
R_{25}	resistance	$T_{vj} = 25^\circ\text{C}$	4.75	5.0	5.25	kΩ
$B_{25/50}$	temperature coefficient			3375		K

Equivalent Circuits for Simulation			*on die level		$T_{vj} = 175^\circ\text{C}$	
$I \rightarrow$	V_0	R_0	IGBT	Diode		
$V_{0\max}$	threshold voltage		0.8	1.2		V
$R_{0\max}$	slope resistance *		2.0	1.0		mΩ



Outlines SimBus F

